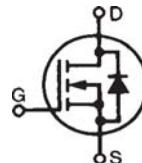


# High Voltage Power MOSFET

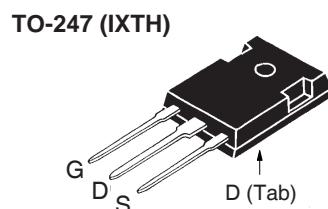
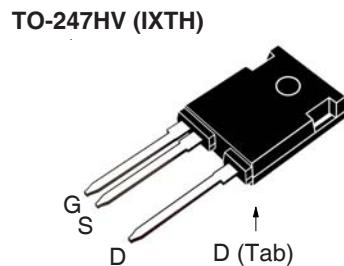
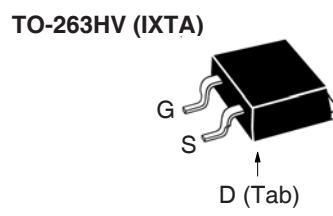
**IXTA1N200P3HV**  
**IXTH1N200P3HV**  
**IXTH1N200P3**

**V<sub>DSS</sub>** = 2000V  
**I<sub>D25</sub>** = 1.0A  
**R<sub>DS(on)</sub>** ≤ 40Ω

## N-Channel Enhancement Mode



Symbol	Test Conditions	Maximum Ratings	
V <sub>DSS</sub>	T <sub>J</sub> = 25°C to 150°C	2000	V
V <sub>DGR</sub>	T <sub>J</sub> = 25°C to 150°C, R <sub>GS</sub> = 1MΩ	2000	V
V <sub>GSS</sub>	Continuous	±20	V
V <sub>GSM</sub>	Transient	±30	V
I <sub>D25</sub>	T <sub>C</sub> = 25°C	1.0	A
I <sub>D110</sub>	T <sub>C</sub> = 110°C	0.6	A
I <sub>DM</sub>	T <sub>C</sub> = 25°C, Pulse Width Limited by T <sub>JM</sub>	3.0	A
P <sub>D</sub>	T <sub>C</sub> = 25°C	125	W
T <sub>J</sub>		- 55 ... +150	°C
T <sub>JM</sub>		150	°C
T <sub>stg</sub>		- 55 ... +150	°C
T <sub>L</sub>	Maximum Lead Temperature for Soldering	300	°C
T <sub>sold</sub>	1.6 mm (0.062in.) from Case for 10s	260	°C
F <sub>c</sub>	Mounting Force (TO-263HV)	10.65 / 22..14.6	N/lb
M <sub>d</sub>	Mounting Torque (TO-247/HV)	1.13/10	Nm/lb.in
Weight	TO-263HV	2.5	g
	TO-247/HV	6.0	g



G = Gate      D = Drain  
S = Source      Tab = Drain

## Features

- High Blocking Voltage
- High Voltage Packages

## Advantages

- Easy to Mount
- Space Savings
- High Power Density

## Applications

- High Voltage Power Supplies
- Capacitor Discharge Applications
- Pulse Circuits
- Laser and X-Ray Generation Systems

Symbol	Test Conditions (T <sub>J</sub> = 25°C, Unless Otherwise Specified)	Characteristic Values		
		Min.	Typ.	Max.
BV <sub>DSS</sub>	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA	2000		V
V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA	2.0		4.0 V
I <sub>GSS</sub>	V <sub>GS</sub> = ±20V, V <sub>DS</sub> = 0V			±100 nA
I <sub>DSS</sub>	V <sub>DS</sub> = V <sub>DSS</sub> , V <sub>GS</sub> = 0V T <sub>J</sub> = 125°C			5 μA 100 μA
R <sub>DS(on)</sub>	V <sub>GS</sub> = 10V, I <sub>D</sub> = 0.5A, Note 1			40 Ω

Symbol	Test Conditions (T <sub>J</sub> = 25°C, Unless Otherwise Specified)	Characteristic Values		
		Min.	Typ.	Max.
<b><math>I_{fs}</math></b>	$V_{DS} = 50V, I_D = 0.5A$ , Note 1	0.4	0.7	S
$C_{iss}$	$V_{GS} = 0V, V_{DS} = 25V, f = 1MHz$	646		pF
$C_{oss}$		50		pF
$C_{rss}$		17		pF
$t_{d(on)}$	<b>Resistive Switching Times</b> $V_{GS} = 10V, V_{DS} = 1kV, I_D = 0.5 \cdot I_{D25}$ $R_G = 5\Omega$ (External)	16		ns
$t_r$		26		ns
$t_{d(off)}$		37		ns
$t_f$		80		ns
$Q_{g(on)}$	$V_{GS} = 10V, V_{DS} = 1kV, I_D = 0.5 \cdot I_{D25}$	23.5		nC
$Q_{gs}$		3.1		nC
$Q_{gd}$		13.3		nC
$R_{thJC}$	TO-247		1.0	°C/W
$R_{thCS}$		0.21		°C/W

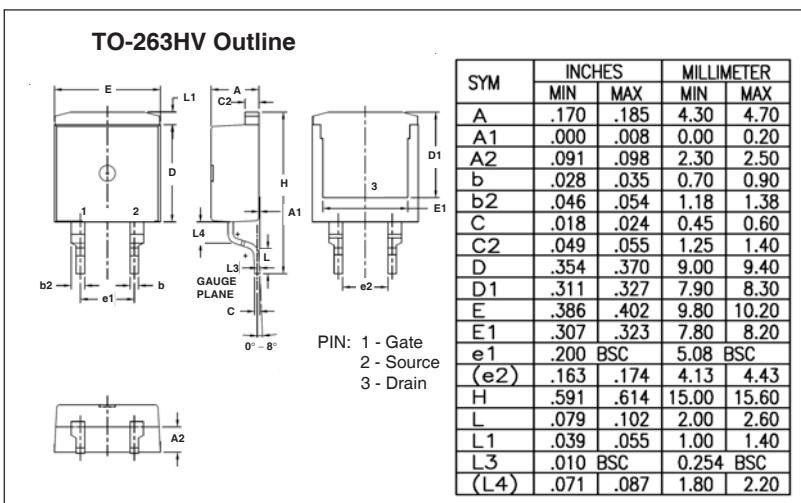
## Source-Drain Diode

Symbol	Test Conditions (T <sub>j</sub> = 25°C, Unless Otherwise Specified)	Characteristic Values		
		Min.	Typ.	Max.
I <sub>s</sub>	V <sub>GS</sub> = 0V			1 A
I <sub>SM</sub>	Repetitive, Pulse Width Limited by T <sub>JM</sub>			4 A
V <sub>SD</sub>	I <sub>F</sub> = I <sub>S</sub> , V <sub>GS</sub> = 0V, Note 1			1.5 V
t <sub>rr</sub>	I <sub>F</sub> = 1A, -di/dt = 100A/μs, V <sub>R</sub> = 100V	2.3		μs

Note: 1. Pulse test,  $t \leq 300\mu\text{s}$ , duty cycle,  $d \leq 2\%$ .

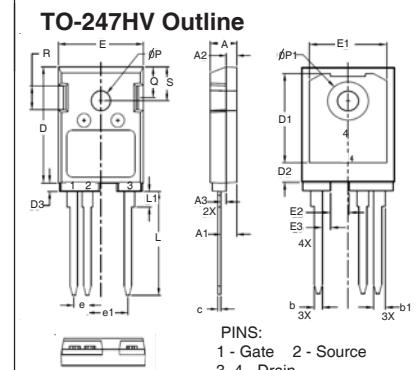
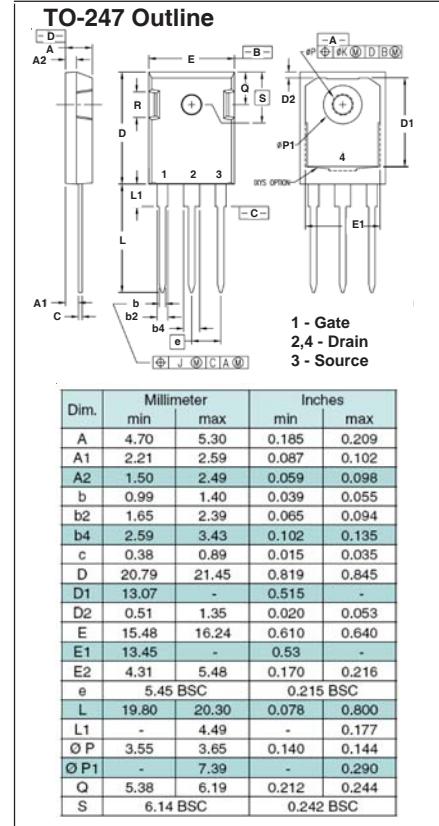
## **PRELIMINARY TECHNICAL INFORMATION**

The product presented herein is under development. The Technical Specifications offered are derived from a subjective evaluation of the design, based upon prior knowledge and experience, and constitute a "considered reflection" of the anticipated result. IXYS reserves the right to change limits, test conditions, and dimensions without notice.

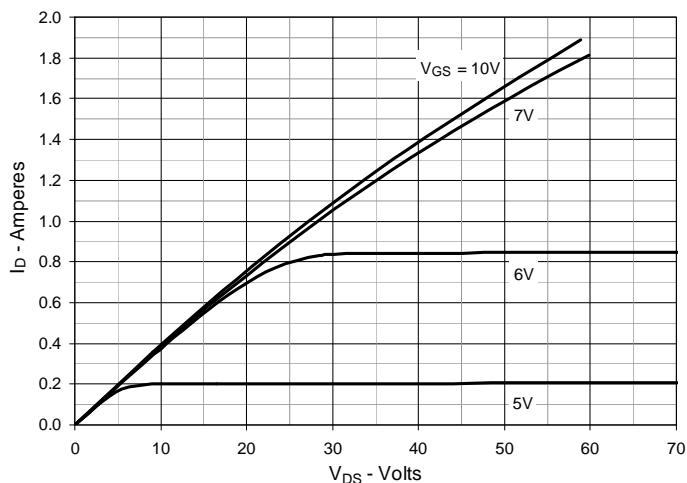
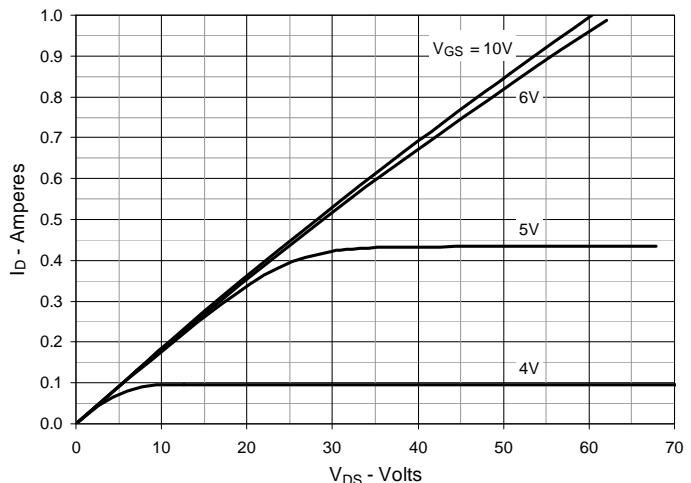
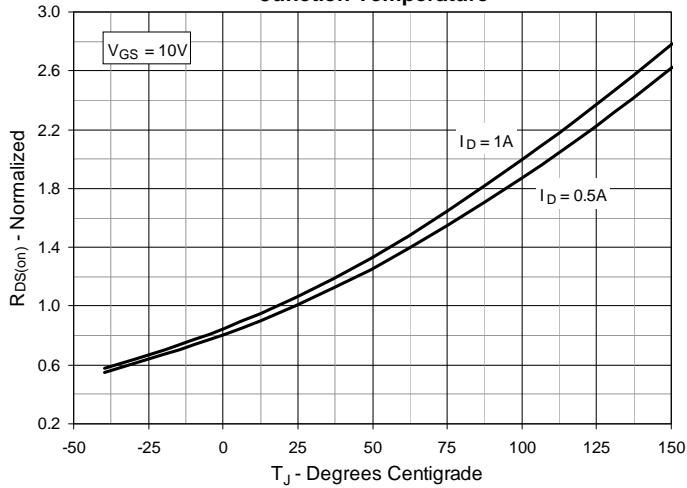
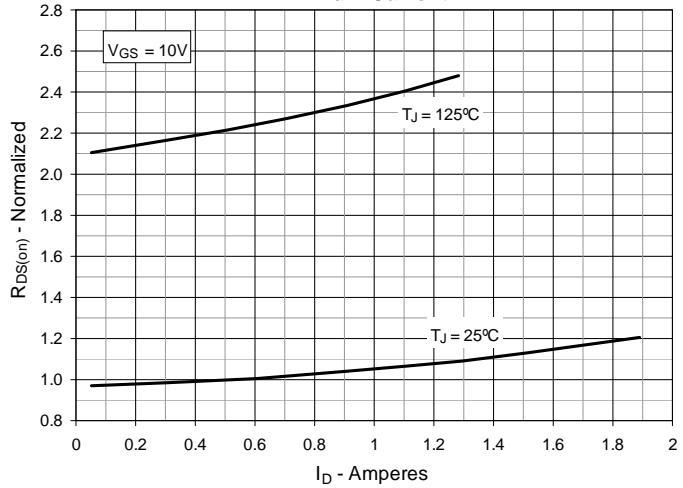
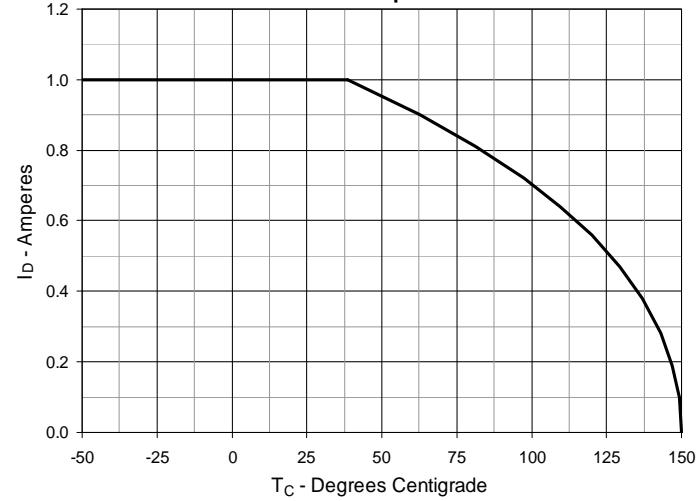
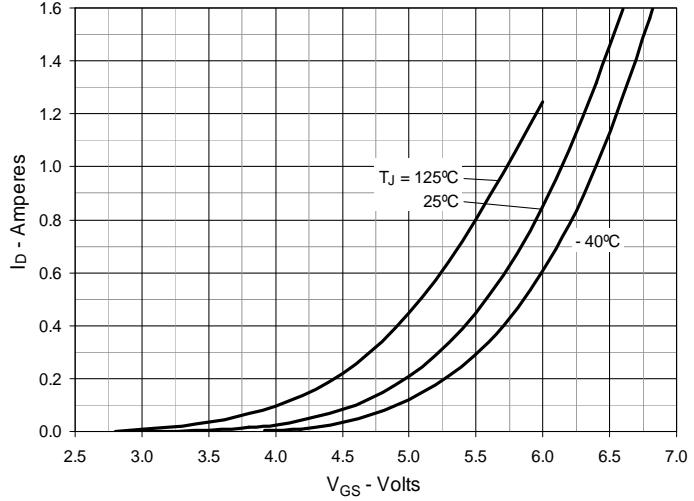


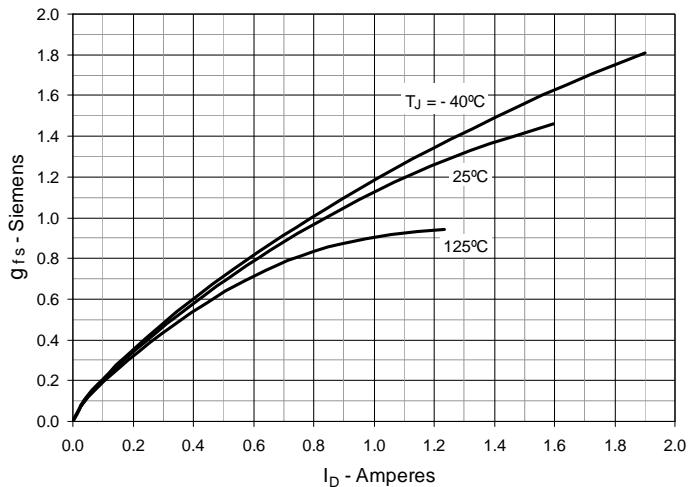
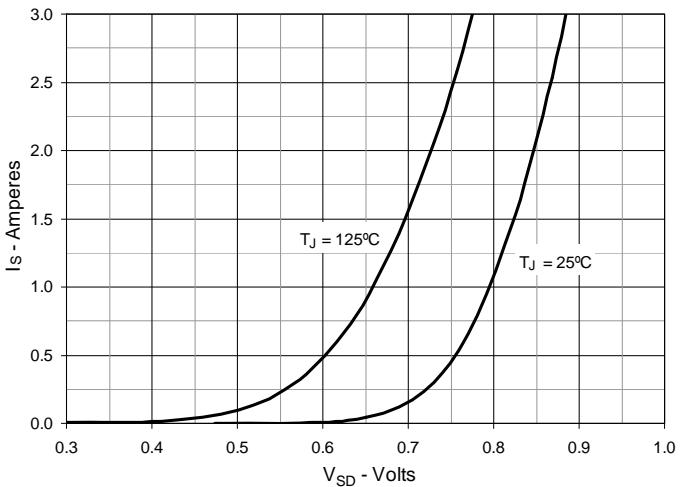
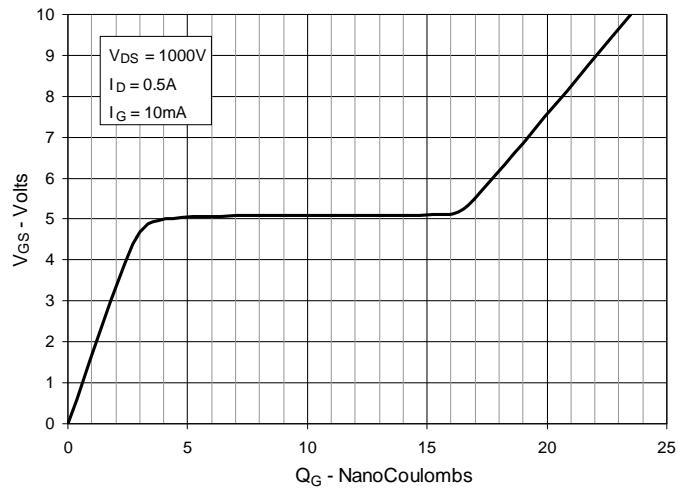
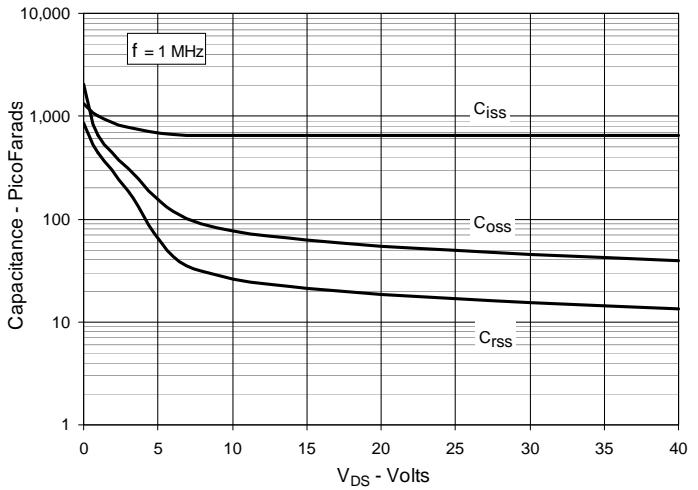
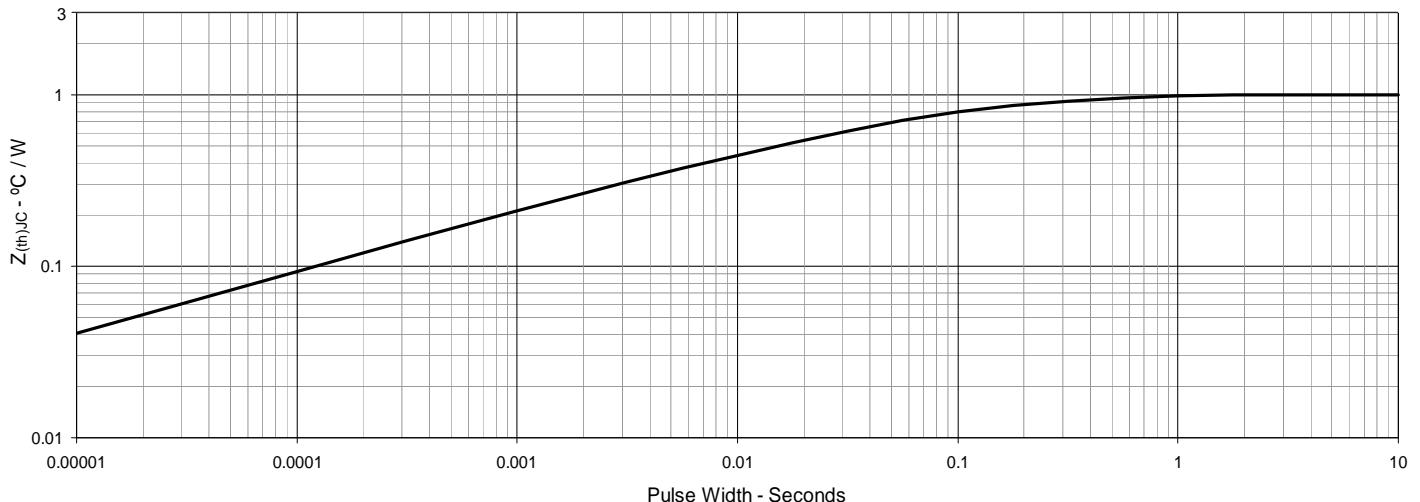
**IXYS Reserves the Right to Change Limits, Test Conditions, and Dimensions.**

IXYS MOSFETs and IGBTs are covered by one or more of the following U.S. patents: 4,835,592; 4,931,844; 5,049,961; 5,237,481; 6,162,665; 6,404,065 B1; 6,683,344; 6,727,585; 7,005,734 B2; 7,157,338B.

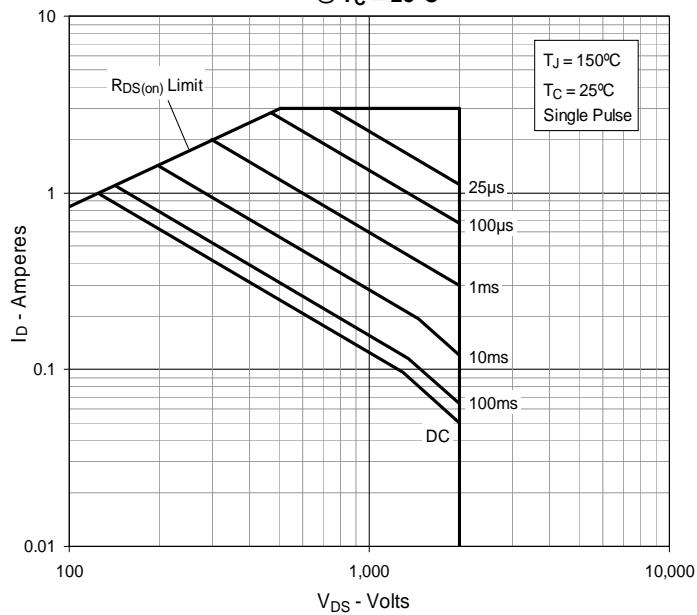


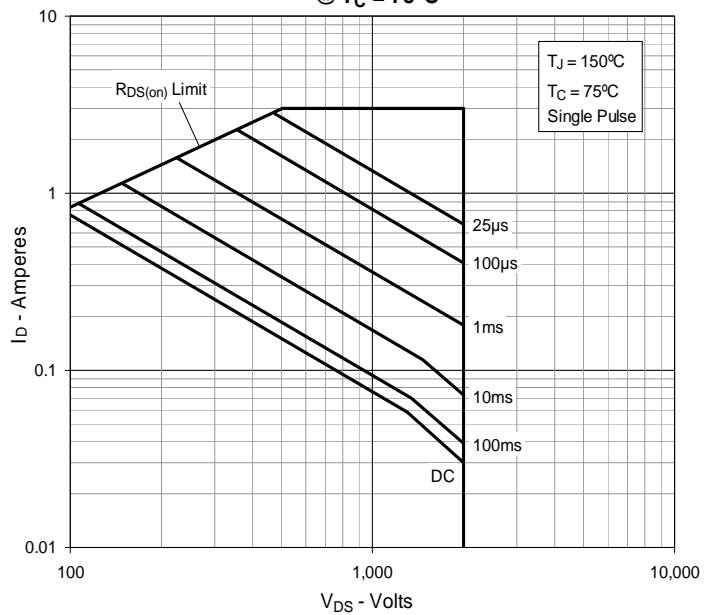
SYM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.193	.201	4.90	5.10
A1	.114	.122	2.90	3.10
A2	.075	.083	1.90	2.10
A3	.035	.043	0.90	1.10
b	.053	.059	1.35	1.50
b1	.075	.083	1.90	2.10
c	.022	.030	0.55	0.75
D	.819	.843	20.80	21.40
D1	.638	.646	16.20	16.40
D2	.134	.146	3.40	3.70
D3	.055	.063	1.40	1.60
E	.622	.638	15.80	16.20
E1	.520	.528	13.20	13.40
E2	.118	.126	3.00	3.20
E3	.051	.059	1.30	1.50
e	.100	BSC	2.54	BSC
e1	.300	BSC	7.62	BSC
L	.732	.748	18.60	19.00
L1	.106	.118	2.70	3.00
ØP	.138	.142	3.50	3.60
ØP1	.272	.280	6.90	7.10
Q	.216	.224	5.50	5.70
R	.165	.169	4.20	4.30
S	.240	.248	6.10	6.30

**Fig. 1. Output Characteristics @  $T_J = 25^\circ\text{C}$** 

**Fig. 2. Output Characteristics @  $T_J = 125^\circ\text{C}$** 

**Fig. 3.  $R_{DS(on)}$  Normalized to  $I_D = 0.5\text{A}$  Value vs. Junction Temperature**

**Fig. 4.  $R_{DS(on)}$  Normalized to  $I_D = 0.5\text{A}$  Value vs. Drain Current**

**Fig. 5. Maximum Drain Current vs. Case Temperature**

**Fig. 6. Input Admittance**


**Fig. 7. Transconductance**

**Fig. 8. Forward Voltage Drop of Intrinsic Diode**

**Fig. 9. Gate Charge**

**Fig. 10. Capacitance**

**Fig. 11. Maximum Transient Thermal Impedance**


**Fig. 12. Forward-Bias Safe Operating Area**

@  $T_C = 25^\circ\text{C}$ 

**Fig. 13. Forward-Bias Safe Operating Area**

@  $T_C = 75^\circ\text{C}$ 


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